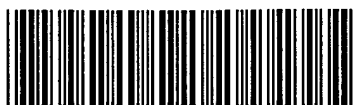


Search Notes

Application/Control No.

10/603,318

Examiner

David L. Vanik

Applicant(s)/Patent under
Reexamination

CHUAH ET AL.

Art Unit

1615

SEARCHED

Class	Subclass	Date	Examiner
424	489	10/13/2005	DV
424	065	10/13/2005	DV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East-See Attached	10/13/2005	DV
East-See Attached	10/13/2005	DV